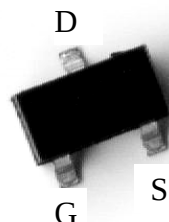


20V N-CHANNEL Enhancement Mode MOSFET

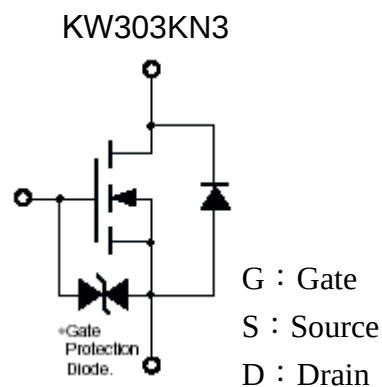
Features:

- Simple drive requirement
- Small package outline
- Pb-free package

SOT-23



BV_{DSS}	20V
I_D	850mA
$R_{DS(on)}@V_{GS}=4.5V, I_D=600mA$	300m Ω (typ)
$R_{DS(on)}@V_{GS}=2.5V, I_D=400mA$	450m Ω (typ)
$R_{DS(on)}@V_{GS}=1.8V, I_D=350mA$	870m Ω (typ)



Ordering Information

Device	Package	Shipping
KW303KN3	SOT-23 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

Absolute Maximum Ratings (Ta=25°C)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	20	V
Gate-Source Voltage	V _{GS}	±8	V
Continuous Drain Current @ TA=25°C, V _{GS} =4.5V	I _D	850	mA
Continuous Drain Current @ TA=70°C, V _{GS} =4.5V		680	mA
Pulsed Drain Current (Notes 1, 2)	I _{DM}	3.5	A
Maximum Power Dissipation@ TA=25°C	P _D	0.35	W
Linear Derating Factor		0.003	W/°C
ESD susceptibility		2000 (Note 3)	V
Operating Junction and Storage Temperature	T _j , T _{stg}	-55~+150	°C

Note : 1. Pulse width limited by maximum junction temperature.

2. Pulse width ≤ 300μs, duty cycle ≤ 2%.

3. Human body model, 1.5kΩ in series with 100pF

Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient(PCB mounted)	R _{th,ja}	360	°C/W

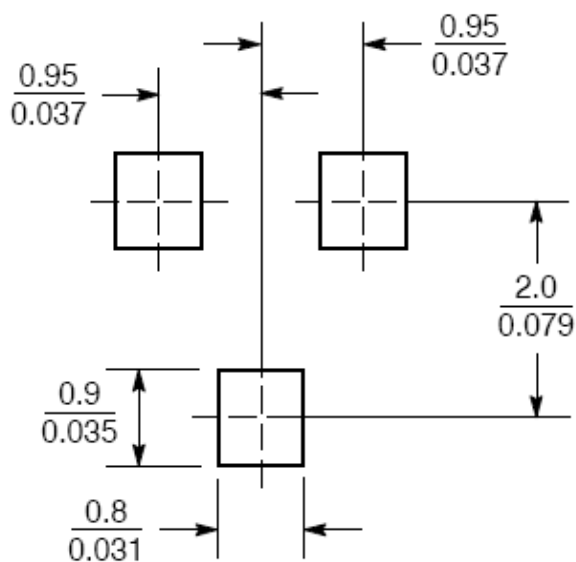
Electrical Characteristics (Tj=25°C, unless otherwise noted)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	20	-	-	V	V _{GS} =0, I _D =250μA
ΔBV _{DSS} /ΔT _j	-	0.02	-	V/°C	Reference to 25°C, I _D =1mA
V _{GS(th)}	0.5	0.92	1.0	V	V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±10	μA	V _{GS} =±8V, V _{DS} =0
I _{DSS}	-	-	1		V _{DS} =20V, V _{GS} =0
	-	-	10		V _{DS} =16V, V _{GS} =0 (T _j =70°C)
*R _{DS(ON)}	-	300	400	mΩ	V _{GS} =4.5V, I _D =600mA
	-	450	600		V _{GS} =2.5V, I _D =400mA
	-	870	1200		V _{GS} =1.8V, I _D =350mA
*G _{FS}	-	1.4	-	S	V _{DS} =5V, I _D =600mA
Dynamic					
C _{iss}	-	60	-	pF	V _{DS} =10V, V _{GS} =0, f=1MHz
C _{oss}	-	14	-		
C _{rss}	-	9	-		
t _{d(ON)}	-	4	-	ns	V _{DS} =10V, I _D =600mA, V _{GS} =10V R _G =3.3Ω, R _D =16.7Ω
t _r	-	10	-		
t _{d(OFF)}	-	15	-		
t _f	-	2	-		

Qg	-	1.3	-	nC	V _{DS} =16V, I _D =600mA, V _{GS} =4.5V
Qgs	-	0.3	-		
Qgd	-	0.5	-		
Source-Drain Diode					
*V _{SD}	-	0.81	1.2	V	V _{GS} =0V, I _S =600mA

*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

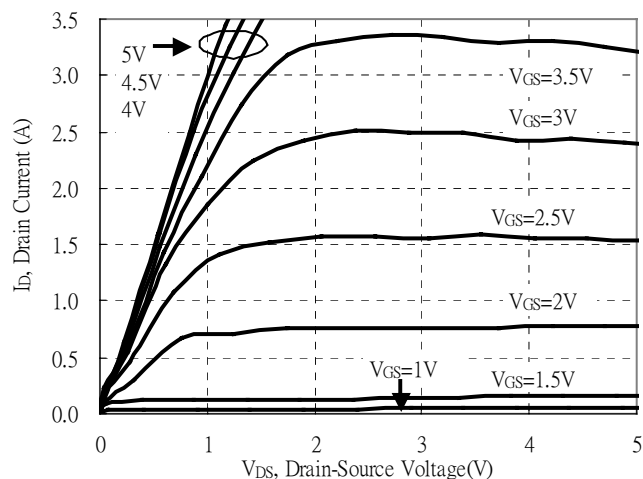
Recommended Soldering Footprint



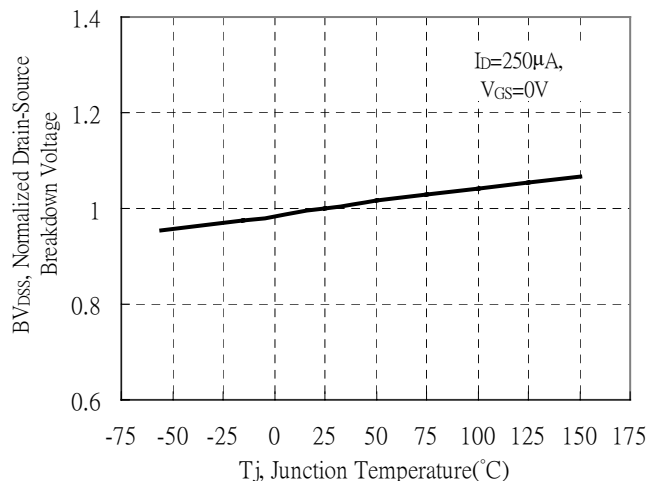
Unit : $\frac{\text{mm}}{\text{inches}}$

Typical Characteristics

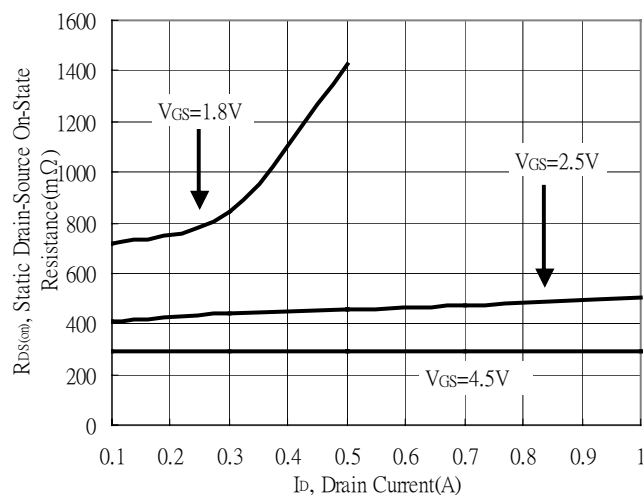
Typical Output Characteristics



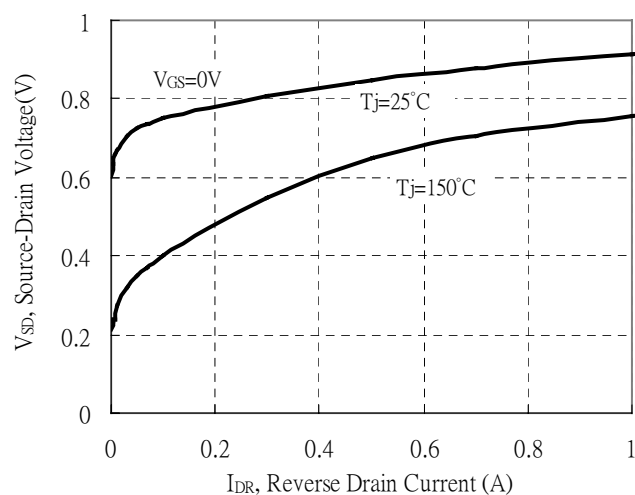
Breakdown Voltage vs Ambient Temperature



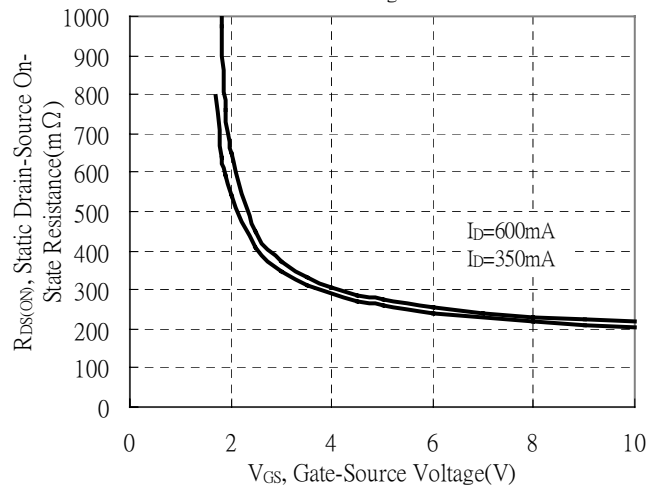
Static Drain-Source On-State resistance vs Drain Current



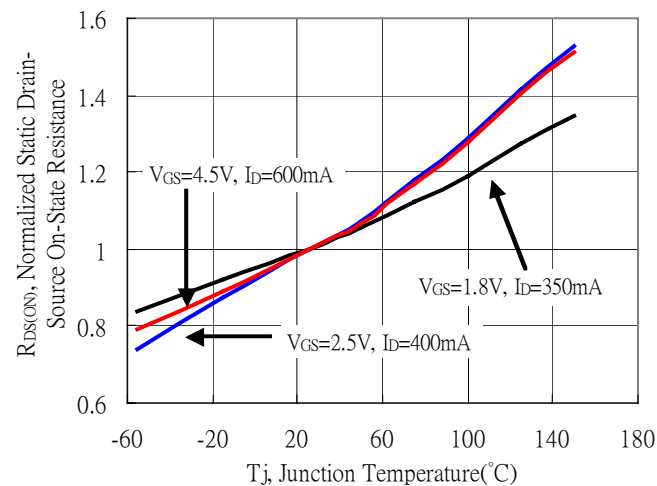
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

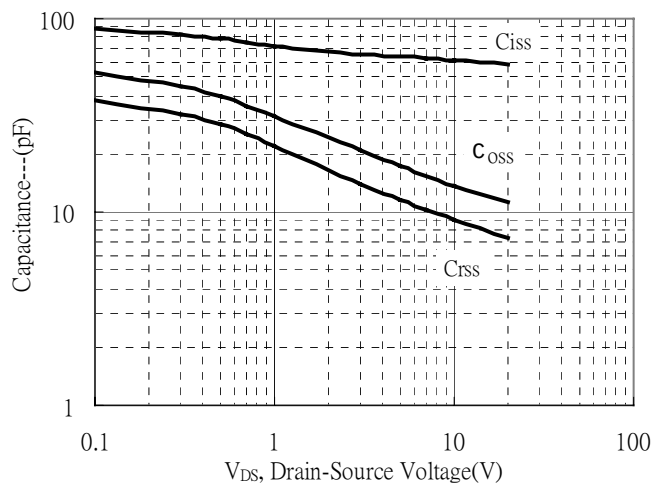


Drain-Source On-State Resistance vs Junction Temperature

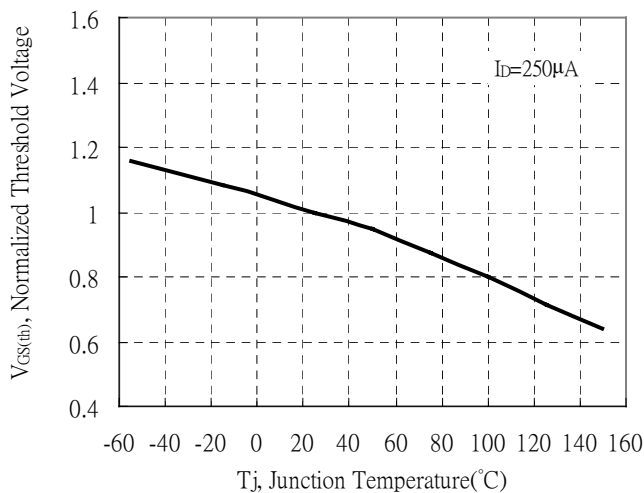


Typical Characteristics(Cont.)

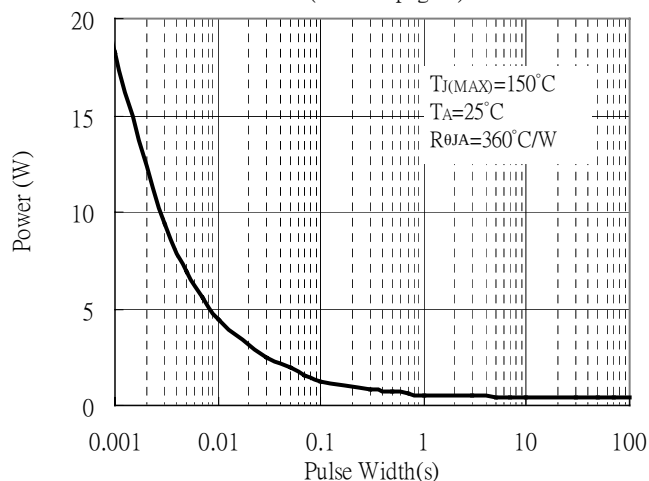
Capacitance vs Drain-to-Source Voltage



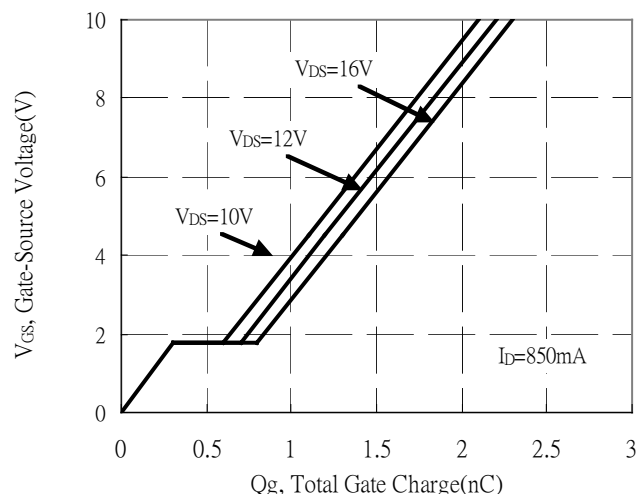
Threshold Voltage vs Junction Temperature



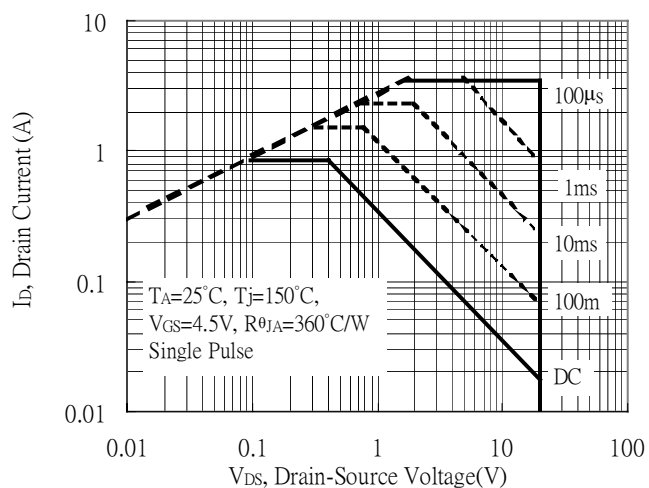
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



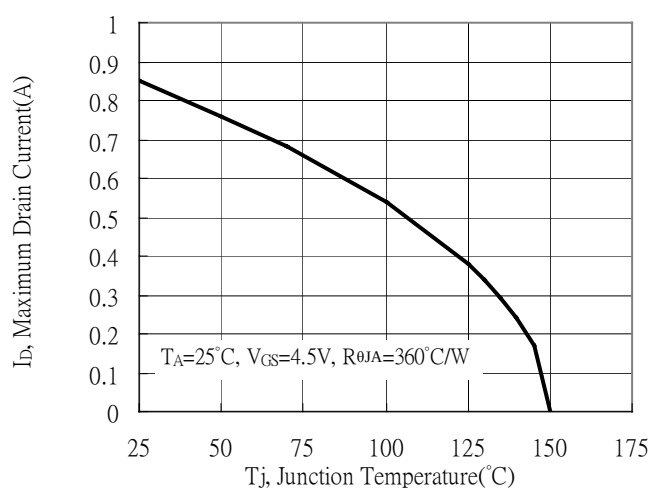
Gate Charge Characteristics



Maximum Safe Operating Area

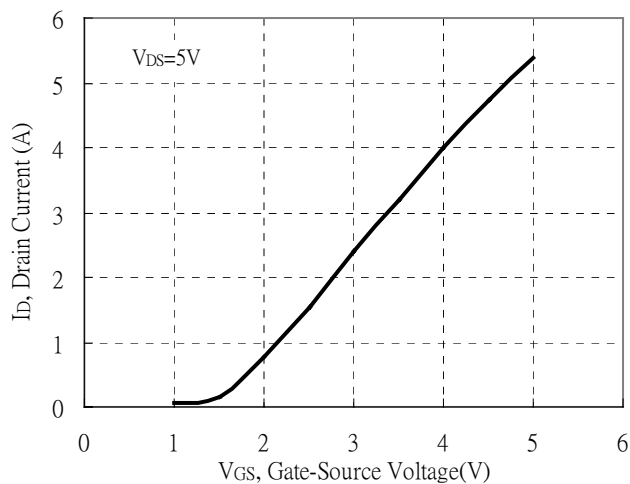


Maximum Drain Current vs Junction Temperature

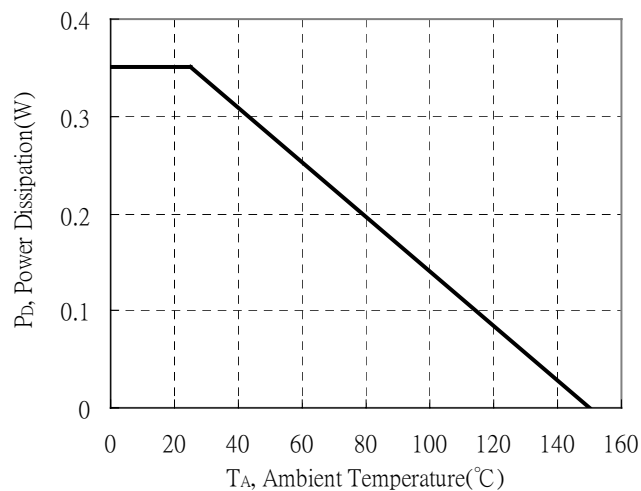


Typical Characteristics(Cont.)

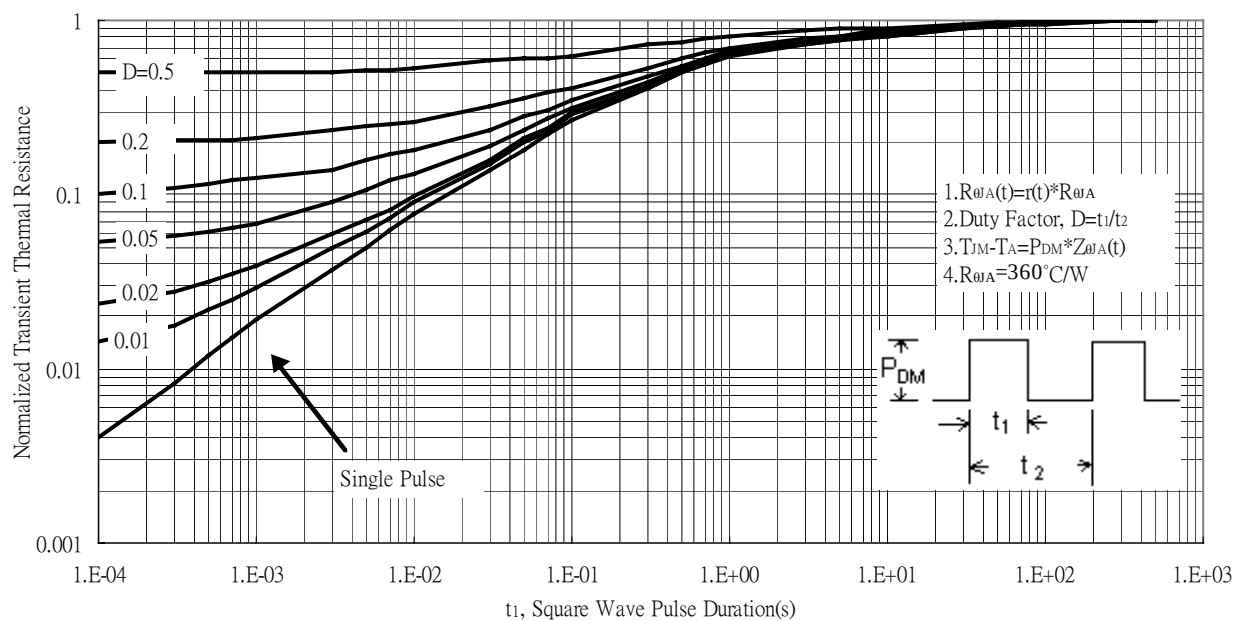
Typical Transfer Characteristics

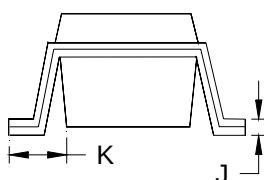
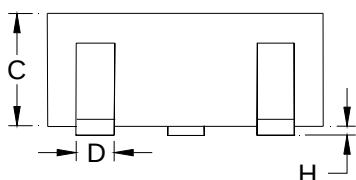
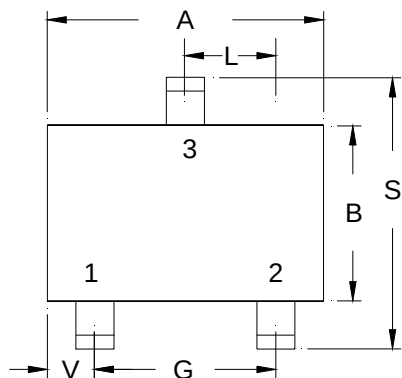


Power Derating Curve

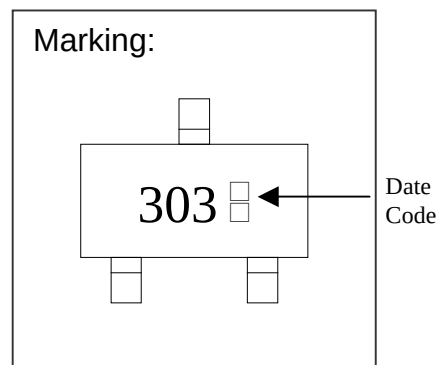


Transient Thermal Response Curves





Marking:



3-Lead SOT-23 Plastic
 Surface Mounted Package
 Code: N3

Style: Pin 1.Gate 2.Source 3.Drain

*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1102	0.1204	2.80	3.04	J	0.0032	0.0079	0.08	0.20
B	0.0472	0.0669	1.20	1.70	K	0.0118	0.0266	0.30	0.67
C	0.0335	0.0512	0.89	1.30	L	0.0335	0.0453	0.85	1.15
D	0.0118	0.0197	0.30	0.50	S	0.0830	0.1161	2.10	2.95
G	0.0669	0.0910	1.70	2.30	V	0.0098	0.0256	0.25	0.65
H	0.0000	0.0040	0.00	0.10					